

# IRF2204PbF

HEXFET® Power MOSFET

## Typical Applications

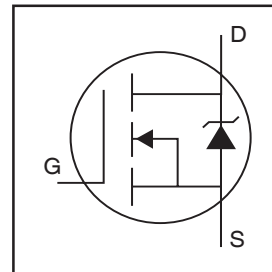
- Industrial Motor Drive

## Features

- Advanced Process Technology
- Ultra Low On-Resistance
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free

## Description

This HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in a wide variety of applications.



$$V_{DS} = 40V$$

$$R_{DS(on)} = 3.6m\Omega$$

$$I_D = 210A^{\textcircled{6}}$$



TO-220AB

## Absolute Maximum Ratings

|                            | Parameter                                  | Max.                     | Units |
|----------------------------|--------------------------------------------|--------------------------|-------|
| $I_D @ T_C = 25^{\circ}C$  | Continuous Drain Current, $V_{GS} @ 10V$   | 210 <sup>⑥</sup>         | A     |
| $I_D @ T_C = 100^{\circ}C$ | Continuous Drain Current, $V_{GS} @ 10V$   | 150 <sup>⑥</sup>         |       |
| $I_{DM}$                   | Pulsed Drain Current <sup>①</sup>          | 850                      |       |
| $P_D @ T_C = 25^{\circ}C$  | Power Dissipation                          | 330                      | W     |
|                            | Linear Derating Factor                     | 2.2                      | W/°C  |
| $V_{GS}$                   | Gate-to-Source Voltage                     | $\pm 20$                 | V     |
| $E_{AS}$                   | Single Pulse Avalanche Energy <sup>②</sup> | 460                      | mJ    |
| $I_{AR}$                   | Avalanche Current <sup>①</sup>             | See Fig.12a, 12b, 15, 16 | A     |
| $E_{AR}$                   | Repetitive Avalanche Energy <sup>②</sup>   |                          | mJ    |
| $T_J$                      | Operating Junction and                     | -55 to + 175             | °C    |
| $T_{STG}$                  | Storage Temperature Range                  |                          |       |
|                            | Soldering Temperature, for 10 seconds      | 300 (1.6mm from case )   |       |
|                            | Mounting Torque, 6-32 or M3 screw          | 10 lbf•in (1.1N•m)       |       |

## Thermal Resistance

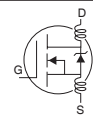
|                 | Parameter                           | Typ. | Max. | Units |
|-----------------|-------------------------------------|------|------|-------|
| $R_{\theta JC}$ | Junction-to-Case                    | —    | 0.45 | °C/W  |
| $R_{\theta CS}$ | Case-to-Sink, Flat, Greased Surface | 0.50 | —    |       |
| $R_{\theta JA}$ | Junction-to-Ambient                 | —    | 62   |       |

# IRF2204PbF

International  
**IR** Rectifier

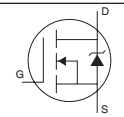
## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

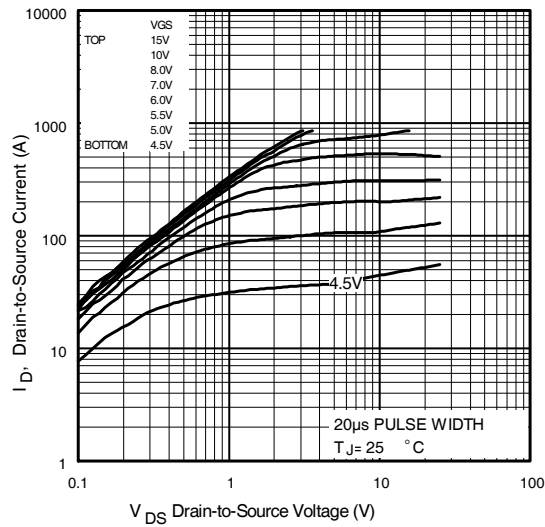
|                                 | Parameter                            | Min. | Typ.  | Max. | Units               | Conditions                                                                  |
|---------------------------------|--------------------------------------|------|-------|------|---------------------|-----------------------------------------------------------------------------|
| $V_{(BR)DSS}$                   | Drain-to-Source Breakdown Voltage    | 40   | —     | —    | V                   | $V_{GS} = 0V$ , $I_D = 250\mu A$                                            |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient  | —    | 0.041 | —    | V/ $^\circ\text{C}$ | Reference to $25^\circ\text{C}$ , $I_D = 1\text{mA}$                        |
| $R_{DS(on)}$                    | Static Drain-to-Source On-Resistance | —    | 3.0   | 3.6  | m $\Omega$          | $V_{GS} = 10V$ , $I_D = 130A$ ④                                             |
| $V_{GS(th)}$                    | Gate Threshold Voltage               | 2.0  | —     | 4.0  | V                   | $V_{DS} = 10V$ , $I_D = 250\mu A$                                           |
| $g_{fs}$                        | Forward Transconductance             | 120  | —     | —    | S                   | $V_{DS} = 10V$ , $I_D = 130A$                                               |
| $I_{DSS}$                       | Drain-to-Source Leakage Current      | —    | —     | 20   | $\mu A$             | $V_{DS} = 40V$ , $V_{GS} = 0V$                                              |
|                                 |                                      | —    | —     | 250  |                     | $V_{DS} = 32V$ , $V_{GS} = 0V$ , $T_J = 150^\circ\text{C}$                  |
| $I_{GSS}$                       | Gate-to-Source Forward Leakage       | —    | —     | 200  | nA                  | $V_{GS} = 20V$                                                              |
|                                 | Gate-to-Source Reverse Leakage       | —    | —     | -200 |                     | $V_{GS} = -20V$                                                             |
| $Q_g$                           | Total Gate Charge                    | —    | 130   | 200  | nC                  | $I_D = 130A$                                                                |
| $Q_{gs}$                        | Gate-to-Source Charge                | —    | 35    | 52   |                     | $V_{DS} = 32V$                                                              |
| $Q_{gd}$                        | Gate-to-Drain ("Miller") Charge      | —    | 39    | 59   |                     | $V_{GS} = 10V$ ④                                                            |
| $t_{d(on)}$                     | Turn-On Delay Time                   | —    | 15    | —    | ns                  | $V_{DD} = 20V$                                                              |
| $t_r$                           | Rise Time                            | —    | 140   | —    |                     | $I_D = 130A$                                                                |
| $t_{d(off)}$                    | Turn-Off Delay Time                  | —    | 62    | —    |                     | $R_G = 2.5\Omega$                                                           |
| $t_f$                           | Fall Time                            | —    | 110   | —    |                     | $V_{GS} = 10V$ ④                                                            |
| $L_D$                           | Internal Drain Inductance            | —    | 4.5   | —    | nH                  | Between lead,<br>6mm (0.25in.)<br>from package<br>and center of die contact |
| $L_S$                           | Internal Source Inductance           | —    | 7.5   | —    |                     |                                                                             |
| $C_{iss}$                       | Input Capacitance                    | —    | 5890  | —    | pF                  | $V_{GS} = 0V$                                                               |
| $C_{oss}$                       | Output Capacitance                   | —    | 1570  | —    |                     | $V_{DS} = 25V$                                                              |
| $C_{rss}$                       | Reverse Transfer Capacitance         | —    | 130   | —    |                     | $f = 1.0\text{MHz}$ , See Fig. 5                                            |
| $C_{oss}$                       | Output Capacitance                   | —    | 8000  | —    |                     | $V_{GS} = 0V$ , $V_{DS} = 1.0V$ , $f = 1.0\text{MHz}$                       |
| $C_{oss}$                       | Output Capacitance                   | —    | 1370  | —    |                     | $V_{GS} = 0V$ , $V_{DS} = 32V$ , $f = 1.0\text{MHz}$                        |
| $C_{oss \text{ eff.}}$          | Effective Output Capacitance ⑤       | —    | 2380  | —    |                     | $V_{GS} = 0V$ , $V_{DS} = 0V$ to $32V$                                      |



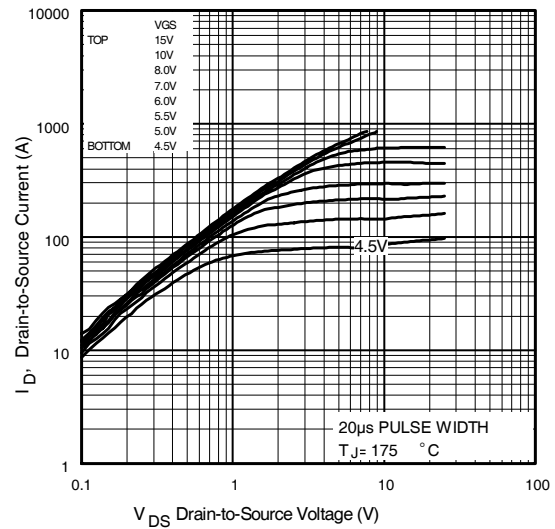
## Source-Drain Ratings and Characteristics

|          | Parameter                                 | Min.                                                                        | Typ. | Max. | Units | Conditions                                                              |
|----------|-------------------------------------------|-----------------------------------------------------------------------------|------|------|-------|-------------------------------------------------------------------------|
| $I_S$    | Continuous Source Current<br>(Body Diode) | —                                                                           | —    | 210⑥ | A     | MOSFET symbol<br>showing the<br>integral reverse<br>p-n junction diode. |
| $I_{SM}$ | Pulsed Source Current<br>(Body Diode) ①   | —                                                                           | —    | 850  |       |                                                                         |
| $V_{SD}$ | Diode Forward Voltage                     | —                                                                           | —    | 1.3  | V     | $T_J = 25^\circ\text{C}$ , $I_S = 130A$ , $V_{GS} = 0V$ ④               |
| $t_{rr}$ | Reverse Recovery Time                     | —                                                                           | 68   | 100  | ns    | $T_J = 25^\circ\text{C}$ , $I_F = 130A$                                 |
| $Q_{rr}$ | Reverse Recovery Charge                   | —                                                                           | 120  | 180  | nC    | $di/dt = 100A/\mu s$ ④                                                  |
| $t_{on}$ | Forward Turn-On Time                      | Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$ ) |      |      |       |                                                                         |

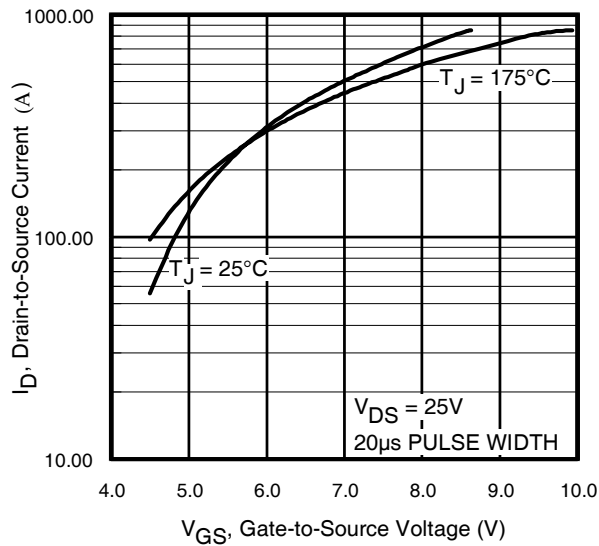




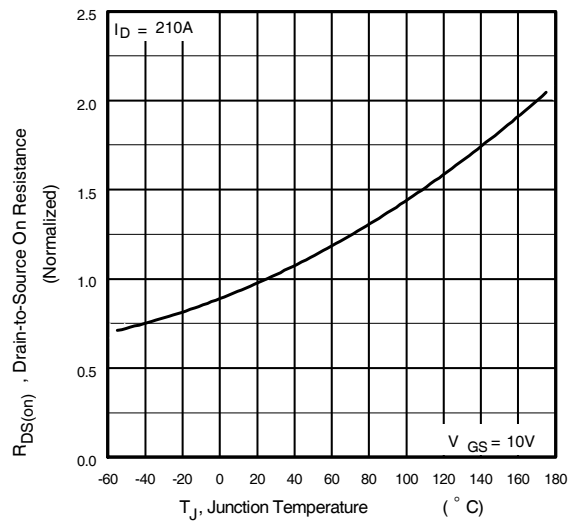
**Fig 1.** Typical Output Characteristics



**Fig 2.** Typical Output Characteristics



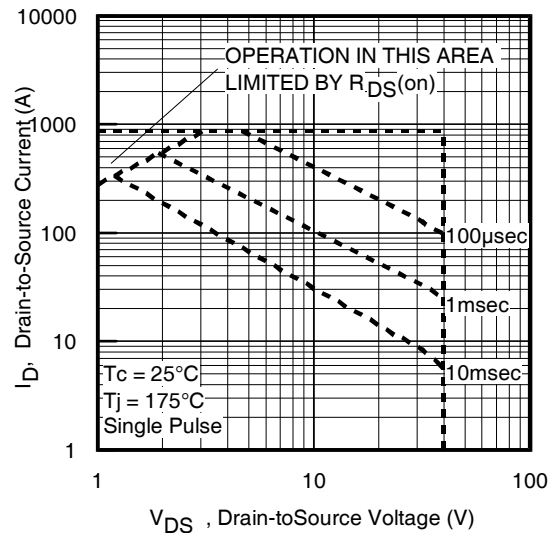
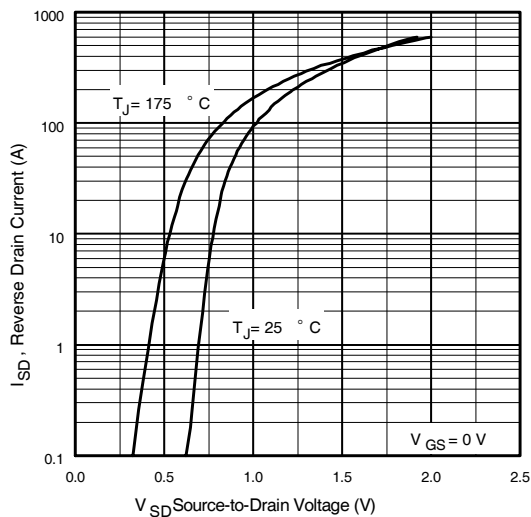
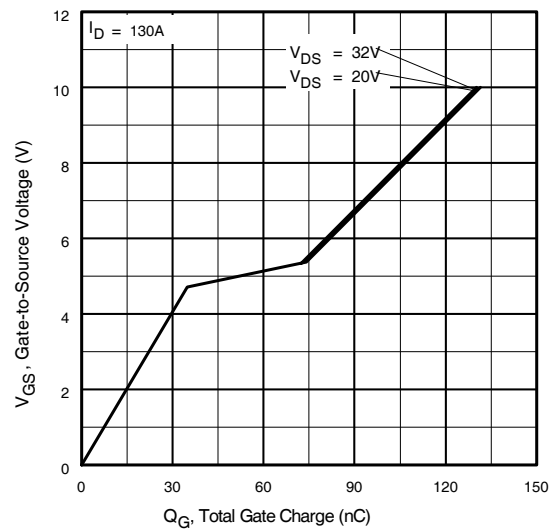
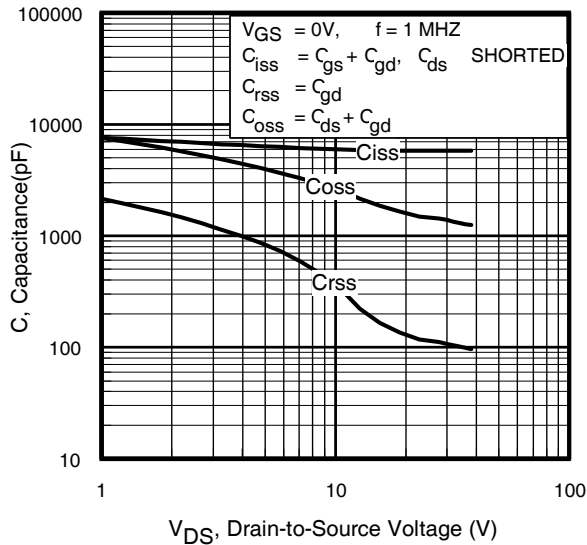
**Fig 3.** Typical Transfer Characteristics

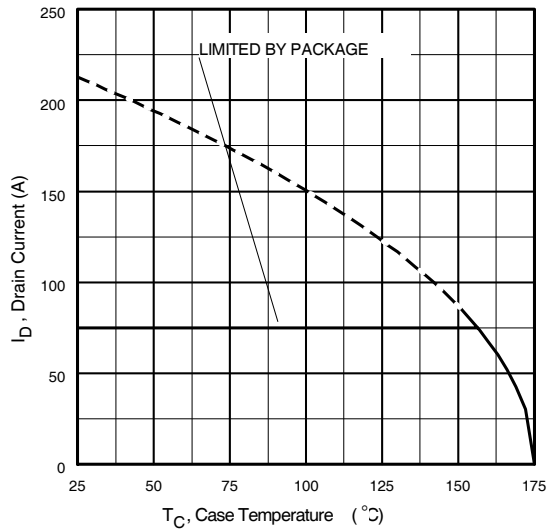


**Fig 4.** Normalized On-Resistance  
Vs. Temperature

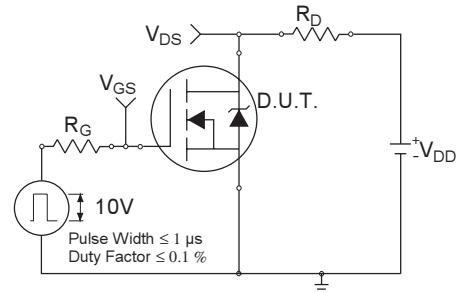
# IRF2204PbF

International  
**IR** Rectifier

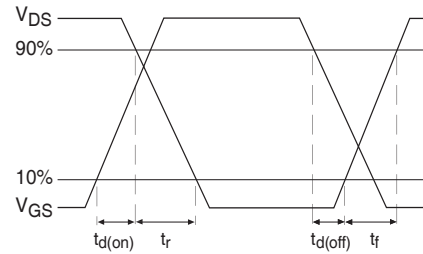




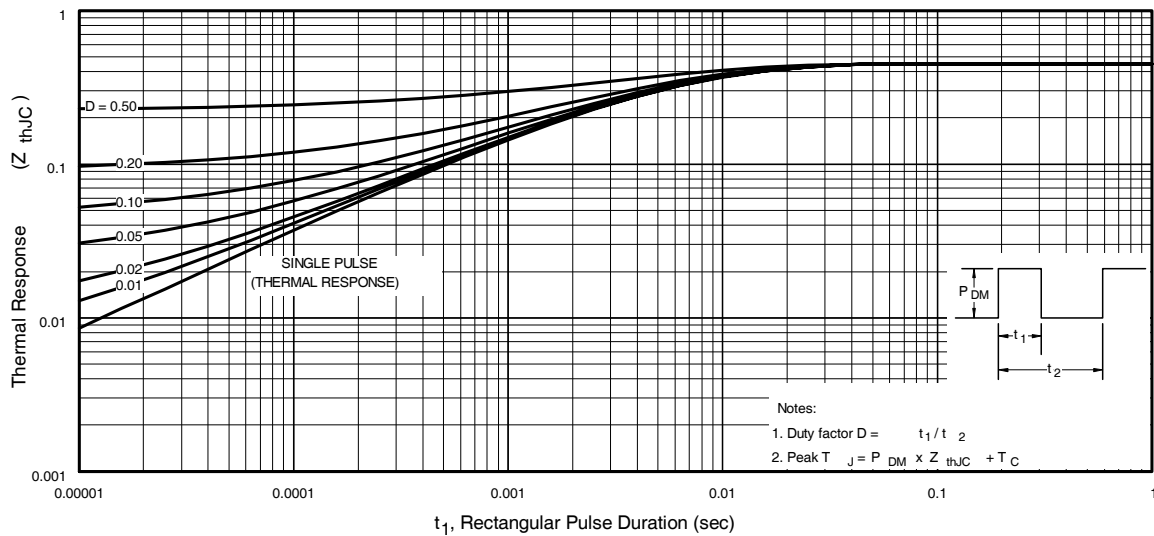
**Fig 9.** Maximum Drain Current Vs. Case Temperature



**Fig 10a.** Switching Time Test Circuit



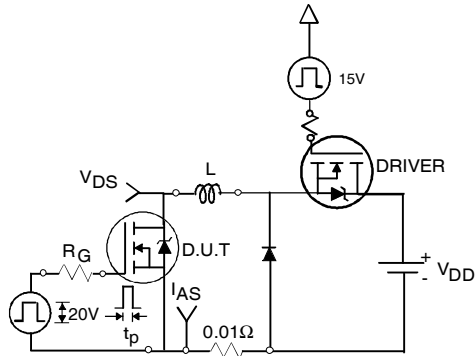
**Fig 10b.** Switching Time Waveforms



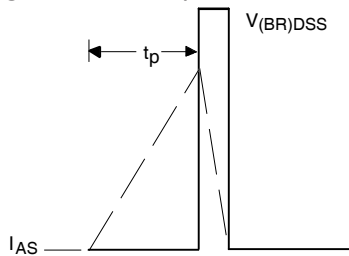
**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case

# IRF2204PbF

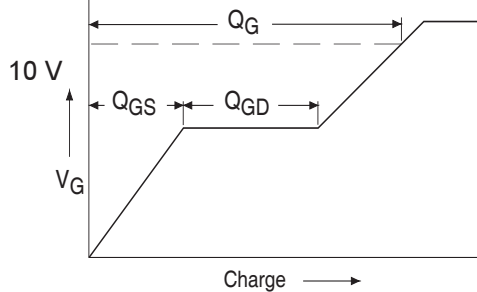
International  
**IR** Rectifier



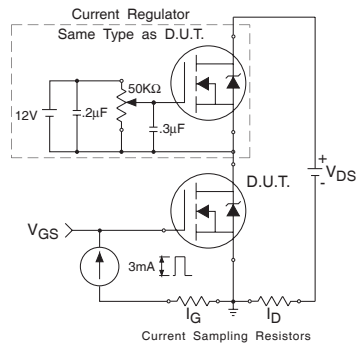
**Fig 12a.** Unclamped Inductive Test Circuit



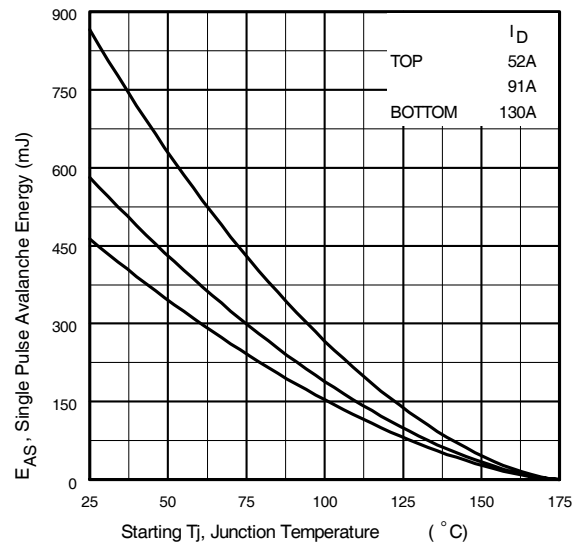
**Fig 12b.** Unclamped Inductive Waveforms



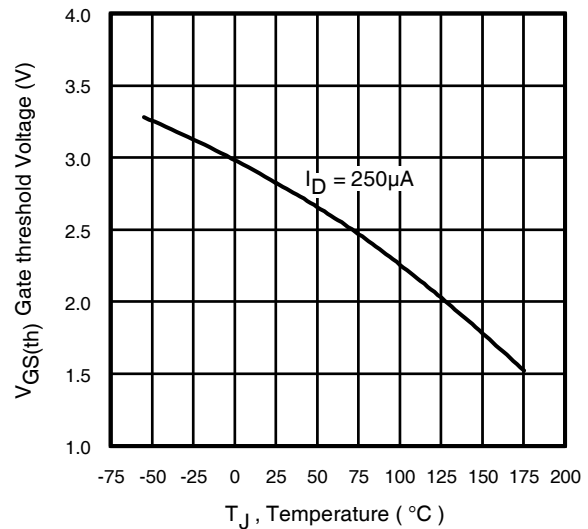
**Fig 13a.** Basic Gate Charge Waveform



**Fig 13b.** Gate Charge Test Circuit



**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current



**Fig 14.** Threshold Voltage Vs. Temperature

[www.irf.com](http://www.irf.com)

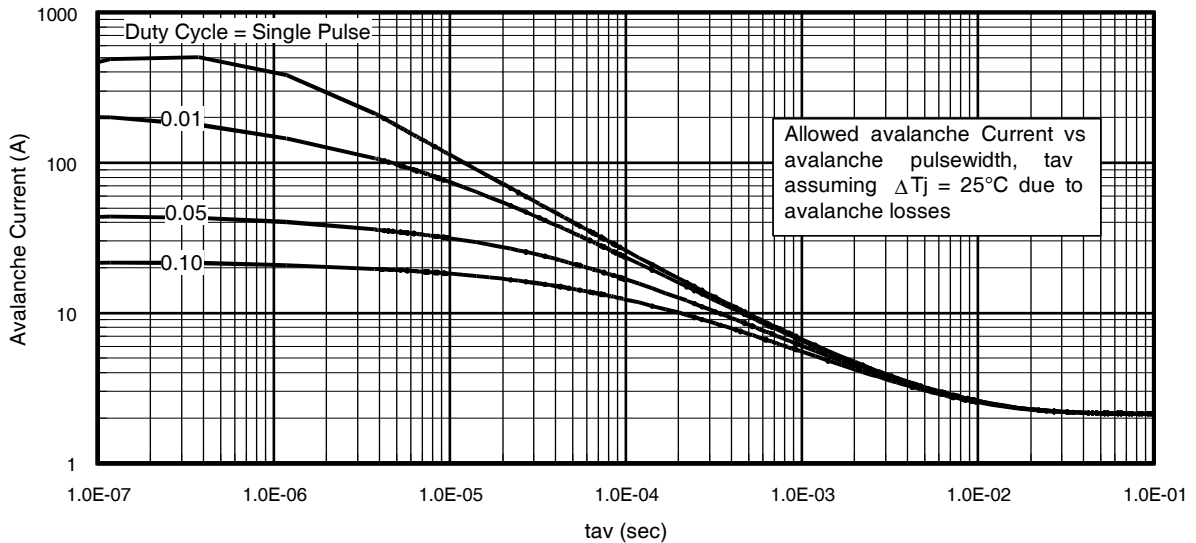


Fig 15. Typical Avalanche Current Vs. Pulsewidth

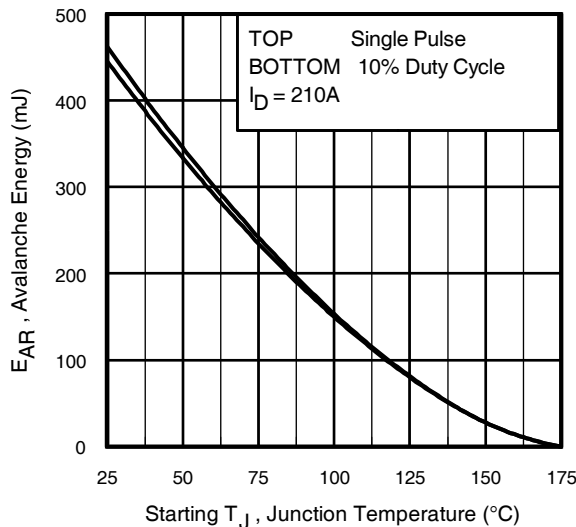


Fig 16. Maximum Avalanche Energy Vs. Temperature

**Notes on Repetitive Avalanche Curves , Figures 15, 16:**  
(For further info, see AN-1005 at [www.irf.com](http://www.irf.com))

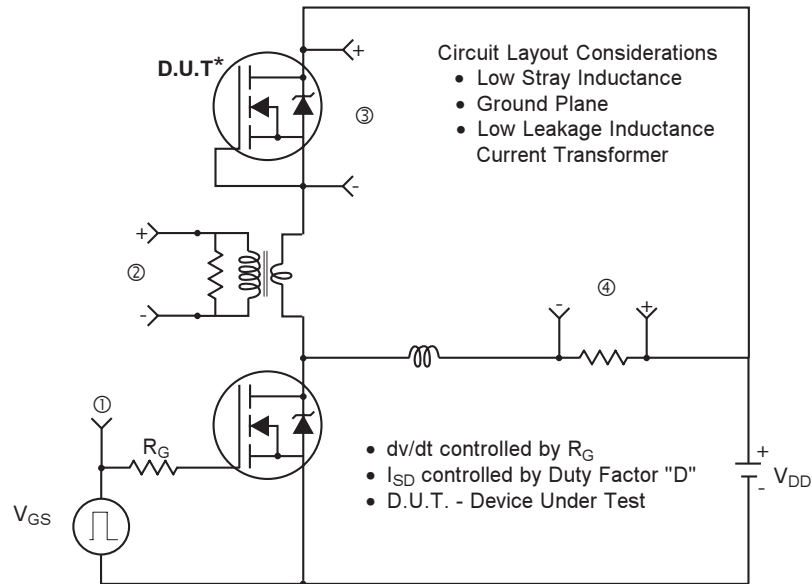
1. Avalanche failures assumption:  
Purely a thermal phenomenon and failure occurs at a temperature far in excess of  $T_{jmax}$ . This is validated for every part type.
2. Safe operation in Avalanche is allowed as long as  $T_{jmax}$  is not exceeded.
3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
4.  $P_{D(ave)}$  = Average power dissipation per single avalanche pulse.
5.  $BV$  = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
6.  $I_{av}$  = Allowable avalanche current.
7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as 25°C in Figure 15, 16).  
 $t_{av}$  = Average time in avalanche.  
 $D$  = Duty cycle in avalanche =  $t_{av} \cdot f$   
 $Z_{thJC}(D, t_{av})$  = Transient thermal resistance, see figure 11)

$$P_{D(ave)} = 1/2 (1.3 \cdot BV \cdot I_{av}) = \Delta T / Z_{thJC}$$

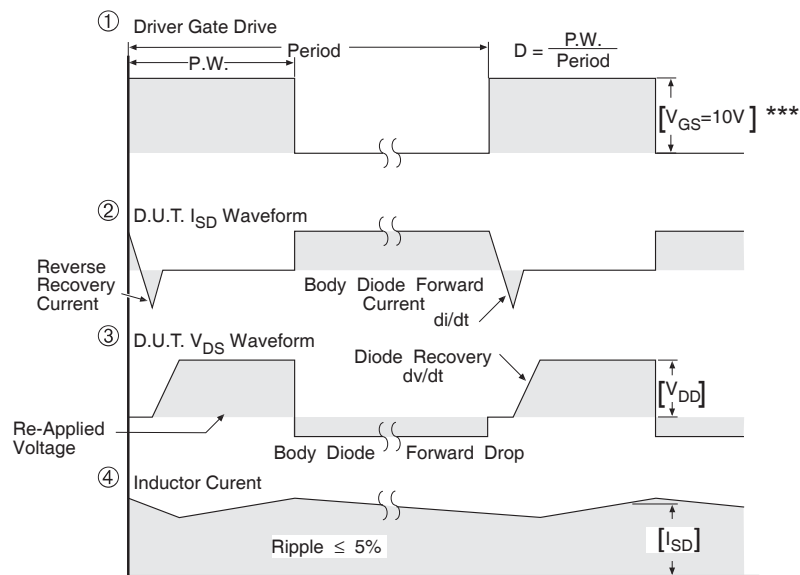
$$I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$$

$$E_{AS(AR)} = P_{D(ave)} \cdot t_{av}$$

## Peak Diode Recovery dv/dt Test Circuit



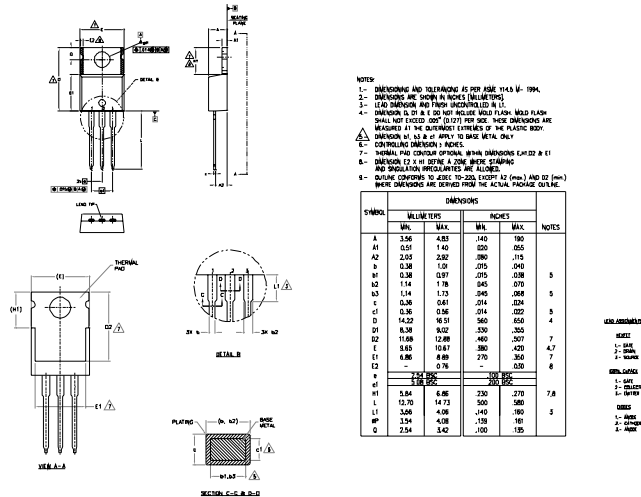
\* Reverse Polarity of D.U.T for P-Channel



\*\*\*  $V_{GS} = 5.0V$  for Logic Level and 3V Drive Devices

**Fig 17.** For N-channel HEXFET® power MOSFETs

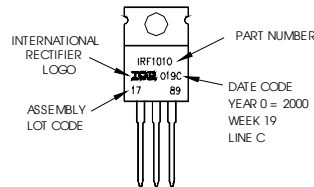
TO-220AB Package Outline(Dimensions are shown in millimeters (inches))



## TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010  
LOT CODE 1789  
ASSEMBLED ON WW 19, 2000  
IN THE ASSEMBLY LINE "C"

Note: "P" in assembly line position  
indicates "Lead - Free"



**TO-220AB package is not recommended for Surface Mount Application.**

### Notes:

1. For an Automotive Qualified version of this part please see <http://www.irf.com/product-info/auto/>
2. For the most current drawing please refer to IR website at <http://www.irf.com/package/>

### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11).
- ② Starting  $T_J = 25^\circ\text{C}$ ,  $L = 0.06\text{mH}$ ,  $R_G = 25\Omega$ ,  $I_{AS} = 130\text{A}$ . (See Figure 12).
- ③  $I_{SD} \leq 130\text{A}$ ,  $di/dt \leq 170\text{A}/\mu\text{s}$ ,  $V_{DD} \leq V_{(BR)DSS}$ ,  $T_J \leq 175^\circ\text{C}$ .
- ④ Pulse width  $\leq 400\mu\text{s}$ ; duty cycle  $\leq 2\%$ .
- ⑤  $C_{OSS}$  eff. is a fixed capacitance that gives the same charging time as  $C_{OSS}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .
- ⑥ Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 75A.
- ⑦ Limited by  $T_{Jmax}$ , see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.

Data and specifications subject to change without notice.  
This product has been designed and qualified for the Industrial market.  
Qualification Standards can be found on IR's Web site.